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INFORMATION DISCLOSURE CITATION IN AN APPLICATION					ATTY. DOCKET NO. 60188-629	SERIAL NO. 10/635,649				
-					APPLICANT Koei HATADE, et al.					
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VP		JP 1	1-96585 A (with English abstract)	04/09/1999	KONICA CORP.			Abstract		
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1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.

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